

PATENT

Case Docket No.:	2001 P 11914 US
Case Desiret 140	20011 11017 00

Date: September 28, 2001



ASSISTANT COMMISSIONER FOR PATENTS Washington, D.C. 20231 **Box PATENT APPLICATION**

Sir:

Transmitted herewith for filing is the patent application of:

Inventor(s):

Linda Chen and Larry Varnerin

For: DIRECT, NON-DESTRUCTIVE MEASUREMENT OF RECESS DEPTH IN A WAFER

This application includes:

Express Mail Label No.:

rins ap	plication includes.
10	pages: specification and claims
2	sheets of drawings, formal/ <u>X</u> Informal photographs
Also en	closed is:
	An Assignment of the invention to Assignee(s):
	X Infineon Technologies North America Corp.
,	International Business Machines Corporation or ITR, LP; IT AG; UMC, etc.
	A certified copy of application
X	Declaration and Power of Attorney
X	Information Disclosure Statement pursuant to 37 CFR 1.56
	X Form PTO-1449
	Form PTO-1595
X	Post Card

The filing fee has been calculated as shown below:

FOR:	(Col. 1) NO. FILED	(Col. 2) NO. EXTRA RATE	OTHER THAN A SMALL ENTITY FEE	
BASIC FEE	XXXXXXX	xxxxxxx	xxxxx	\$710
TOTAL CLAIMS	<u>10</u> - 20 =	<u>0</u>	X \$18 =	\$ <u>0</u>
INDEP CLAIMS	<u>2</u> -3=	<u>0</u>	X \$80 =	\$ <u>0</u>
* MULTIPLE DEPENDENT CLAIM PRESENTED				\$0
ASSIGNMENT(S) <u>0</u>			X \$40 =	\$0

TOTAL \$710.00

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A fee of __\$0.00__ to cover recordation of the Assignment(s). 19-2179 in the amount of \$710.00. Please charge my Deposit Account No. Х duplicate copy of this sheet is enclosed. The Commissioner is hereby authorized to charge payment of the following fees associated with this communication or credit any overpayment to Deposit Account No. 19-2179. A duplicate copy of this sheet is enclosed. Any additional filing fees required under 37 CFR 1.16. Х Any patent application processing fees under 37 CFR 1.17. The Commissioner is hereby authorized to charge payment of the following fees during the <u>X</u> pendency of this application or credit any overpayment to Deposit Account No. 19-2179. A duplicate copy of this sheet is enclosed. Any patent application processing fees under 37 CFR 1.17 Any filing fees under 37 CFR 1.16 for presentation of extra claims

Respectfully submitted,

Date: 9/28/01/

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APPLICATION FOR LETTERS PATENT OF THE UNITED STATES

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TITLE OF INVENTION: DIRECT, NON-DESTRUCTIVE MEASUREMENT OF RECESS DEPTH IN A WAFER

> TO WHOM IT MAY CONCERN, THE FOLLOWING IS A SPECIFICATION OF THE AFORESAID INVENTION